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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/555,447	FUJINO ET AL.	
Examiner	Art Unit	
Eugenia Wang	1745	

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	DATE	EXMR
Updated Inventor Search	6/21/2007	EW
Updated keyword search (EAST -		
USPAT, USPGPUB, USOCR) *note, most likely classed in 429/246,	6/21/2007	EW
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